

Notice of References Cited	Application/Control No. 10/648,353	Applicant(s)/Patent Under Reexamination KATAYAMA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0220366	10-2005	Watanabe et al.	382/305
*	B	US-2003/0038895	02-2003	Yang et al.	348/569
*	C	US-6,353,461	03-2002	Shore et al.	348/722
*	D	US-6,246,402	06-2001	Setogawa et al.	715/723
*	E	US-6,246,401	06-2001	Setogawa et al.	715/723
*	F	US-5,963,704	10-1999	Mimura et al.	386/95
*	G	US-6,795,011	09-2004	Berthoud et al.	341/173
*	H	US-6,208,341	03-2001	van Ee et al.	715/716
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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